## Search Notes



Applicant(s)/Patent under Reexamination

Aр

 10/662,209
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SEARCHED					
Class	Subclass	Date	Examiner		
348	143 148 159	7/18/2007	YL		
375	240.01				
H04N	7/18				
update	search	11/12/2007	YL		
update	search	3/12/2008	YL		

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Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	